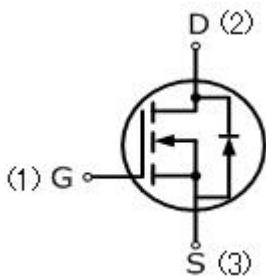


150N06Y

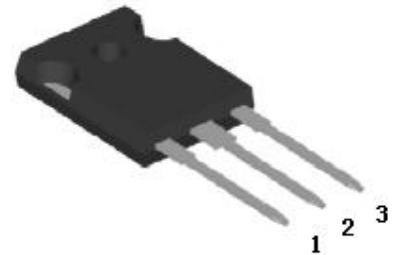
150 Amps,60 Volts N-CHANNEL MOSFET

FEATURE

- 150A,60V, $R_{DS(ON)MAX}=6m\Omega @V_{GS}=10V/30A$
- Low gate charge
- Low C_{iss}
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



TO-247



Absolute Maximum Ratings ($T_C=25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	150N06Y	UNIT
Drain-Source Voltage	V_{DSS}	60	V
Gate-Source Voltage	V_{GSS}	± 30	
Continuous Drain Current	I_D	150	A
Pulsed Drain Current(Note1)	I_{DM}	450	
Single Pulse Avalanche Energy (Note 2)	E_{AS}	450	mJ
Avalanche Current(Note1)	I_{AR}	30	A
Reverse Diode dV/dt (Note 3)	dv/dt	5.5	V/ns
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 to +150	$^\circ\text{C}$
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	T_L	260	$^\circ\text{C}$
Mounting Torque	6-32 or M3 screw	10	lbf • in
		1.1	N • m

Thermal Characteristics

Parameter	Symbol	TO-247	Units
Thermal resistance , Junction to Case	$R_{th(J-c)}$	0.8	$^\circ\text{C}/\text{W}$
Maximum Power Dissipation	P_D	156	W

Electrical Characteristics ($T_c=25^\circ\text{C}$, unless otherwise noted)						
Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	60	—	—	V
Breakdown Temperature Coefficient	$\Delta BV_{DSS} / \Delta T_J$	Reference to 25°C , $I_D=250\mu A$	—	0.6	—	$V/^\circ\text{C}$
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=60V, V_{GS}=0V$	—	—	1	μA
Gate-Body Leakage Current, Forward	I_{GSSF}	$V_{GS}=20V, V_{DS}=0V$	—	—	100	nA
Gate-Body Leakage Current, Reverse	I_{GSSR}	$V_{GS}=-20V, V_{DS}=0V$	—	—	-100	nA
On Characteristics						
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS}=10V, I_D=250\mu A$	2	—	4	V
Drain-Source On-State Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=30A$	—	4.5	6.0	$m\Omega$
Dynamic Characteristics						
Input Capacitance	C_{iss}	$V_{DS}=30V, V_{GS}=0V,$ $f=1.0\text{MHZ}$	—	4550	—	pF
Output Capacitance	C_{oss}		—	625	—	pF
Reverse Transfer Capacitance	C_{rss}		—	360	—	pF
Switching Characteristics						
Turn-On Delay Time	$t_{d(on)}$	$V_{DD}=30V, I_D=30A,$ $R_G=0.4\Omega$ (Note4,5)	—	78	—	ns
Turn-On Rise Time	t_r		—	119	—	ns
Turn-Off Delay Time	$t_{d(off)}$		—	692	—	ns
Turn-Off Fall Time	t_f		—	310	—	ns
Total Gate Charge	Q_g	$V_{DS}=30V, I_D=30A,$ $V_{GS}=10V,$ (Note4,5)	—	217	—	nC
Gate-Source Charge	Q_{gs}		—	45	—	nC
Gate-Drain Charge	Q_{gd}		—	30	—	nC
Drain-Source Body Diode Characteristics and Maximum Ratings						
Continuous Diode Forward Current	I_S		—	—	150	A
Pulsed Diode Forward Current	I_{SM}		—	—	450	A
Diode Forward Voltage	V_{SD}	$I_S=30A, V_{GS}=0V$	—	—	1.3	V
Reverse Recovery Time	t_{rr}	$V_{GS}=0V, I_S=30A,$ $dI_F/dt=100A/\mu s,$ (Note4)	—	37	—	ns
Reverse Recovery Charge	Q_{rr}		—	23	—	μC

Notes

1. Repetitive Rating; pulse width limited by maximum junction temperature.
2. $L=0.1\text{mH}, R_g=25\Omega, I_{AS}=100A$, starting $T_J=25^\circ\text{C}$.
3. $I_{SD} \leq I_D, dI/dt=200A/\mu s, V_{DD} \leq BV_{DSS}$, starting $T_J=25^\circ\text{C}$.
4. Pulse width $\leq 300\mu s$; duty cycle $\leq 2\%$.
5. Repetitive rating; pulse width limited by maximum junction temperature.

RATING AND CHARACTERISTIC CURVES



Peak Diode Recovery dv/dt Test Circuit



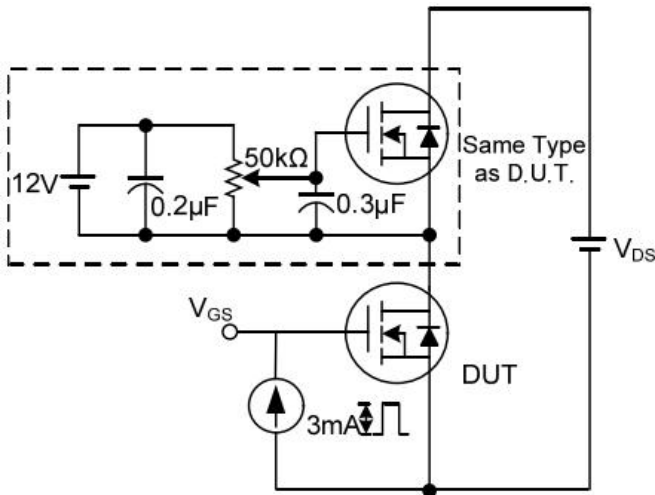
Peak Diode Recovery dv/dt Waveforms



Switching Test Circuit



Switching Waveforms



Gate Charge Test Circuit



Gate Charge Waveform

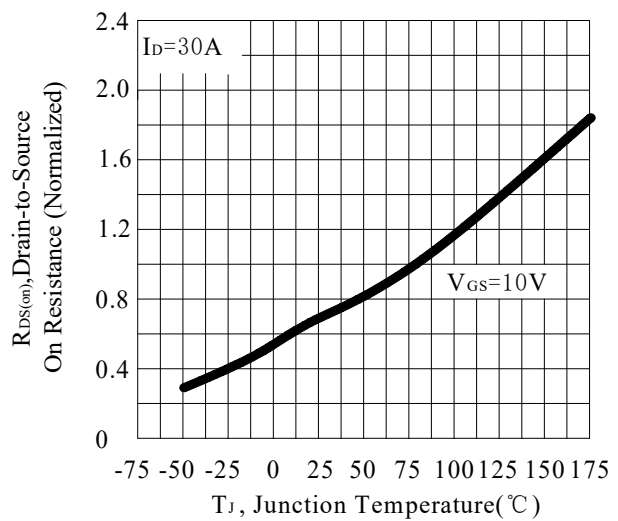
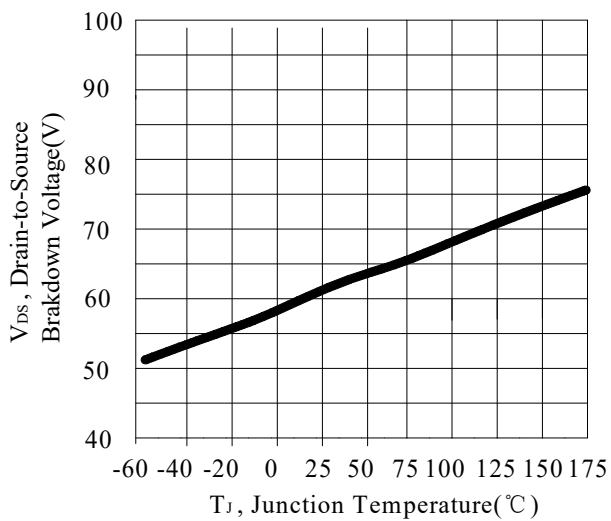
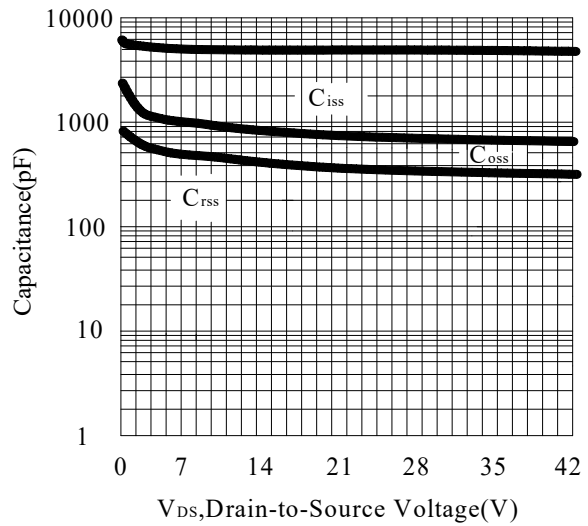
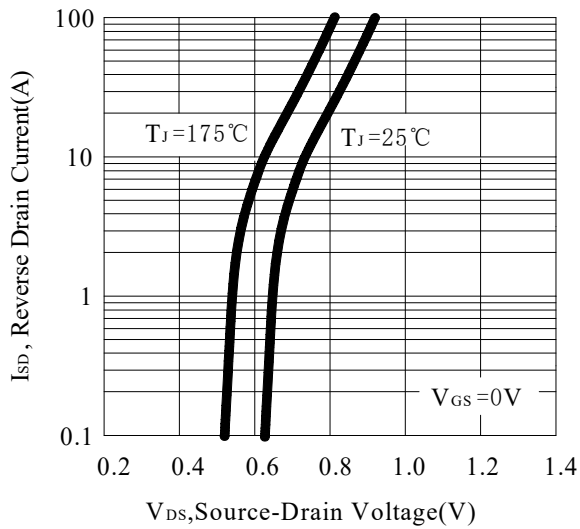
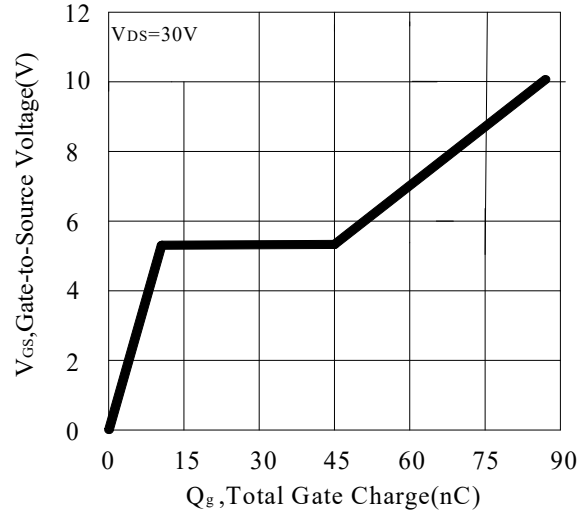
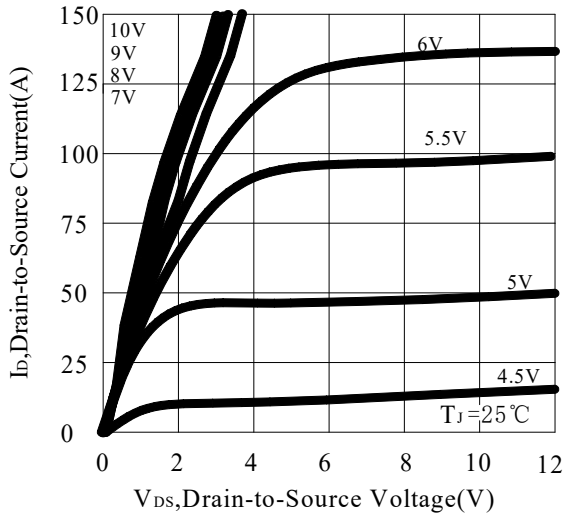


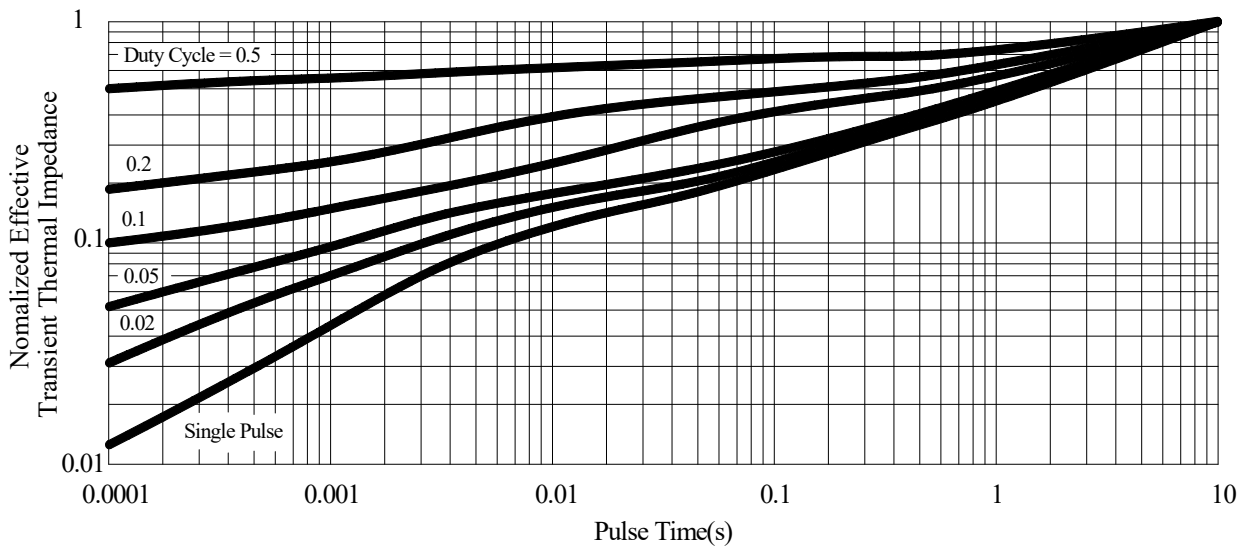
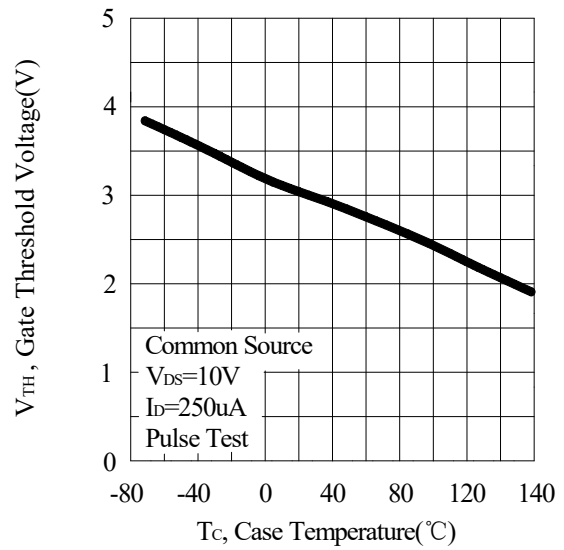
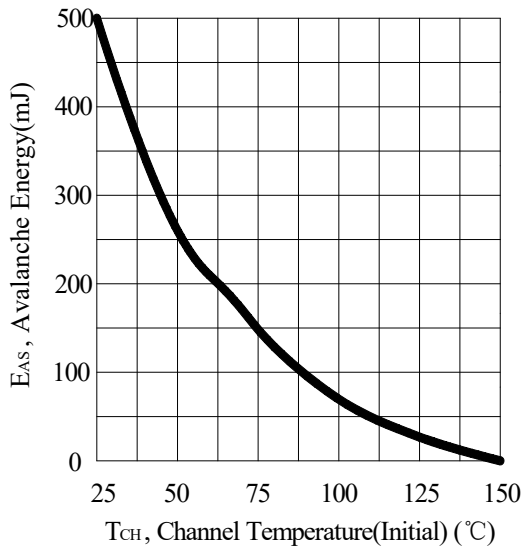
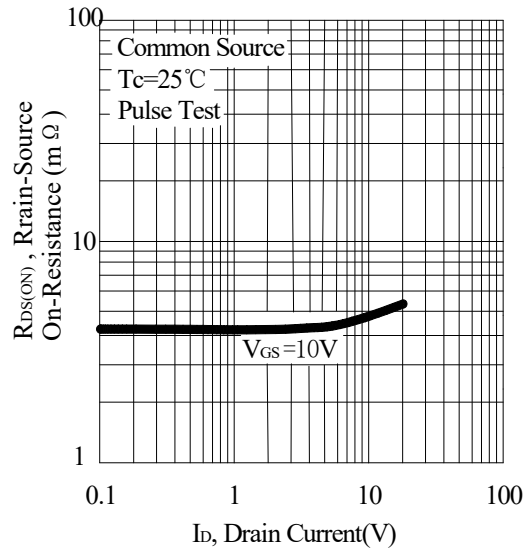
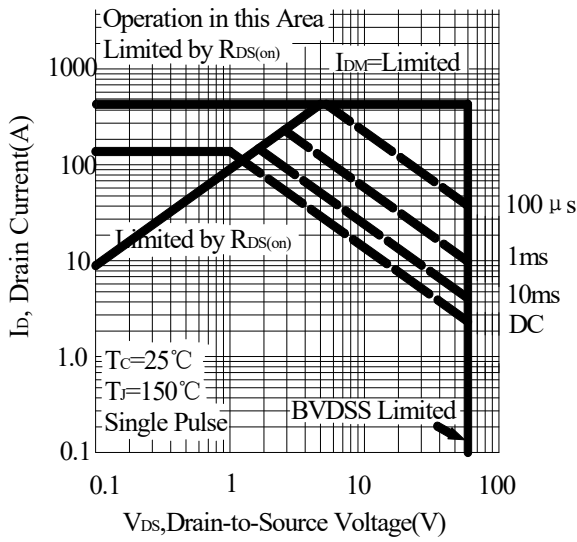
Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

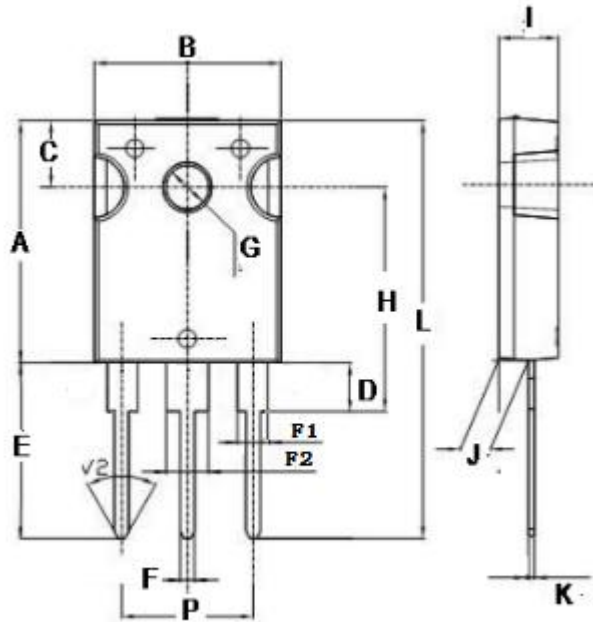
RATING AND CHARACTERISTIC CURVES





PACKAGE OUTLINE DIMENSIONS

TO-247



Dim	Min	Max
A	20.0	22.0
B	15.5	16.0
C	5.7	6.3
D	4.0	4.4
E	19.0	21.0
F	1.1	1.3
G	3.5	3.8
H	18.3	20.2
I	4.9	5.2
J	2.3	2.5
K	0.55	0.65
L	39.0	42.0
P	10.7	10.9
F1	1.9	2.1
F2	2.9	3.1
mm		